

<b>Notice of References Cited</b>	Application/Control No. 10/668,246	Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner Huan H. Tran	Art Unit 2861	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,484,759	01-1996	Suto et al.	503/227
	B	US-5,318,943	06-1994	Ueno et al.	503/227
	C	US-5,342,671	08-1994	Stephenson, Stanley W.	428/195.1
	D	US-5,146,344	09-1992	Bennett et al.	358/296
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 09-137082	05-1997	Japan	-----	G03G007/00
	O	JP 08-022217	01-1996	Japan	Satoshi et al	G03G021/00
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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